Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/705,572	MITCHELL ET AL.	
Examiner	Art Unit	
John Kim	1723	

class 01, 2.1, 505,	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH I (INCLUDING SEAR		)
	DATE	EXMR
See EAST Search History	1/18/2006	YK
EAST Search History	8/24/2006	JK